



SUBJECT AREAS:
ELECTRONIC PROPERTIES
AND MATERIALS
SURFACES, INTERFACES AND
THIN FILMS
MOLECULAR SELF-ASSEMBLY
IMAGING TECHNIQUES

CORRIGENDUM: Assessment of Scanning Tunneling Spectroscopy Modes Inspecting Electron Confinement in Surface-Confined Supramolecular Networks

Wolfgang Krenner, Dirk Kühne, Florian Klappenberger & Johannes V. Barth

This Article contains errors in Equations (1) and (3). In these equations “ eV ” should read “ eV_B ”, and in Equation (1) “ $(eV-E)$ ” should read “ $(E-eV_B)$ ”.

Equation (1) should read:

$$I_T \propto \int_0^{eV_B} \rho_T(E - eV_B) \rho_S(\vec{r}_T, E) T(z, eV_B, E) dE$$

Equation (3) should read:

$$\left. \frac{dI}{dV} \right|_{V_B} \propto \rho_S(eV_B) T(z, eV_B) + \int_0^{eV_B} \rho_S(E) \frac{\partial T(eV_B, E)}{\partial V} dE.$$

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